Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/801,219	MEGAW ET AL.	
Examiner	Art Unit	
Y. J. Han	2838	

SEARCHED					
Class	Subclass	Date	Examiner		
323	312				
	313				
_	314				
	315				
	316				
	907				
341	119				
327	539				
326	32				
323	318				
Search	updated	7/10/2006	/JH/		
Search	updated	10/28/2006	JH		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
-					
See sea	rch report	10/30/2006	JH		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		